## **ON Semiconductor**



# Final Product/Process Change Notification Document # : FPCN21411X

Issue Date: 3 August 2016

Title of Change:	Qualification of ON Semiconductor SSL factory located in Shenzhen, China for Bump Post-Test Production (Wafer-saw, visual inspection, Tape & Reel) for NCP333FCT2G.		
Proposed first ship date:	10 November 2016 or earlier upon customer approval		
Contact information:	Contact your local ON Semiconductor Sales Office or <todd.manes@onsemi.com></todd.manes@onsemi.com>		
Samples:	Contact your local ON Semiconductor Sales Office		
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or <ken.fergus@onsemi.com>.</ken.fergus@onsemi.com>		
Type of notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact < <u>PCN.Support@onsemi.com</u> >.		
Change Part Identification:	Affected parts will be identified by the date code.		
Change category:	🔲 Wafer Fab Change 🔲 Assembly Change 🔲 T	est Change 🛛 Other Wafer-saw, VI, T&R	
Change Sub-Category(s): Manufacturing Site Change/ Manufacturing Process Char Sites Affected: All site(s) not ap		<ul> <li>Datasheet/Product Doc change</li> <li>Shipping/Packaging/Marking</li> <li>Other: Wafer-saw, Visual Inspection, T&amp;R</li> <li>External Foundry/Subcon site(s)</li> <li>Select Site</li> </ul>	
for bump product post-test ope performed at the ON Semiconductor S on Semiconductor SSL in Shenzhe All production operations that oc facility or production test facility a Note that the post-test process is o SSL performs	nnounce a capacity expansion qualification of its SSL factor rations (wafer-saw, visual inspection, Tape & Reel) fo ctor facility located in Seremban, Malaysia. Upon expirate SSL in Shenzhen, China facility or at ON Semiconductor, Se on, China is certified to be compliant to ISO-9001 and ISO- ccur through the test process will remain unchanged for the being made. Only the operations that occur after test a the same between SSL and Seremban (existing factory), w 100% manual inspection in tape &R using hot-seal cover tape	r the NCP333FCT2G. These operations are currently ion or approval of this FPCN, these operations may be eremban, Malaysia facility. 14001. r the NCP333FCT2G. No changes to wafer, fab, bump are affected by this notification.	
No changes to the Finished Goods or product packing will be made.			



### **Qualification Data Summary:**

#### QV DEVICE NAME: NCP333FCT2G

Test	Sample Size	Results
Saw		
100% Visual Inspection	3 lots/ 77 units	Pass
Kerf Width Measurement	3 lots/ 77units	Pass
Backside Wall Integrity	3 lots/ 5 units	Pass
Tape and Reel		
Peel test		Pass
Electronic Map vs Skeleton verification	3 wafers	Pass
De-tape and Inspect	1 reel, 100%	Pass

Visual Inspection and pick & place electronic map verification has been performed at the ON Semiconductor SSL site to ensure all rejects will continue to be detected and removed from production.

#### **Electrical Characteristic Summary:**

Electrical characteristics are not impacted.

#### List of Affected Standard Parts:

Part Number	Qualification Vehicle
NCP333FCT2G	NCP333FCT2G